



Thermal studies of DEPFET cooling for Belle II

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Barcelona, 8.10.2009

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Assumptions



- 17 W total power dissipation (8 W at each module end)
- to simulate the bump bonding: a layer (50 μ m thickness) with λ =5 W/mK between the chips and the silicon
- 20°C ambient temperature







Contact cooling with diamond strips



- two diamond strips (7mm×0.4mm×50mm) glued on the both ends of the module
- adhesive layer: 50 μ m thick, thermal conductivity λ =5 W/mK
- −30°C cooling temperature





Cooling from below



- diamond strip glued on the underside of the silicon
- advantages: simple mounting, large contact area (98 mm²)
- disadvantage: larger distance between the inner layer and the beam pipe



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- advantages: no heat transfer through the silicon, heat is lead away directly from where it is produced
- disadvantage: chips have to be of the same height, mechanical stress to the bonds



Min: 33.456

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Cooling from above (with TPG-bridge)



- diamond strip glued on the upside of the silicon (42 mm² contact area)
- TPG-bridge (10mm×0.2mm×14mm) to connect the diamond directly to the chips
- $\blacksquare~\sim 7-8^\circ C$ higher temperature











best results from diamond glued directly on the chips

- nearly the same results from gluing the diamond on the underside
- $\blacksquare ~\sim 8^\circ C$ higher temperature on the edge of the active area with a TPG-bridge

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Air flow



- cooling by diamond strips glued on the underside of the silicon
- −30°C cooling temperature
- air flow along the module (air temperature 20°C)





 \rightarrow temperature at the center of the module decreases significantly with higher air velocity (nearly no change on the edges of the active area)

Image: A matrix and a matrix

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Possible solution



- $-35^{\circ}C$ cooling temperature
- $5^{\circ}C$ air temperature, 5 m/s air velocity





Conclusions



- A cooling temperature of −30°C or lower is needed (if the diamond ist 7 mm wide and 0.4 mm thick)
- Slightly higher cooling temperature may be enough with a wider/thicker diamond strip and/or lower ambient temperature
- Similar results for all three possible diamond positions
- DEPFET temperature is 7°C higher when cooled with the TPG-bridge as by cooling from below, has to be verified experimentally

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Air flow is needed to cool down the center of the module







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Experimental setup



Piece of silicon (15mm×80mm×0.5mm = half ladder) heated by SMD-resistors and cooled through a diamond strip (8mm×50mm×0.4mm)

First setup: diamond glued on the underside of the silicon (below the resistors)





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New setup



New setup: diamond glued on the upside of the silicon. For the connection with the heat source a TPG stripe (0.3 mm thick) was glued on the resistors and on the diamond



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- 15°C temperature gain when using the TPG-strip
- even with the TPG-strip the temperature is 17°C higher than by cooling from below

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temperature by $\sim 0.7^{\circ}C$

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First conclusions



- Cooling only through a diamond glued on the upside of the silicon is not effective
- Setup with TPG-strip is very sensitive to mechanical stress and gluing, results are not exactly reproducible (preliminary) → more tests necessary
- Relatively high temperature already with 300μ m thick TPG-strip \rightarrow is it reasonable to test thinner TPG-strips?
- For cooling temperature higher than -5°C: 1°C lower cooling temperature leads to 0.7°C lower silicon temperature → -32°C cooling temperature needed to reduce silicon temperature to 30°C (for 6 W)

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Thank you

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